



The 17th Workshop on First-Principles Computational Materials Physics

Unusual Thermoelectric Behaviors in Topological Insulator Nanostructures

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What is thermoelectricity?

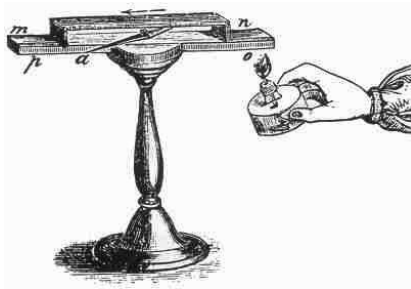
- **Thermoelectricity:** The science and technology considering the conversion between the electrical energy and the thermal energy.



https://en.wikipedia.org/wiki/Thomas_Johann_Seebeck

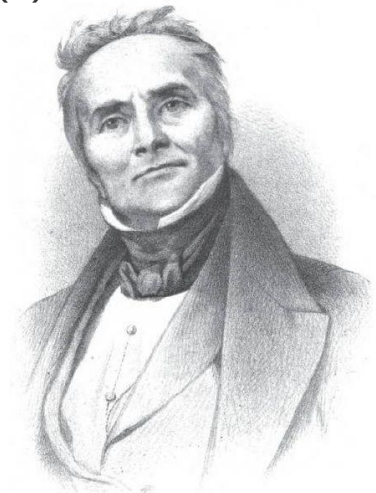
Seebeck Effect (1821-3)

Using temperature difference to generate electrical power



<http://www.thermoelectrics.caltech.edu/thermoelectrics/history.html>

Instrument used by Seebeck to observe the deflection of a compass needle (a) due to a thermoelectric induced current



Peltier Effect (1834)

Using the electrical power to create temperature difference

https://en.wikipedia.org/wiki/Jean_Charles_Athanase_Peltier



Applications of Thermoelectricity

- Thermoelectric generator
- Thermoelectric cooler
- Gas Company (CPC)
- Steel-making Company (CSC)
- Portable Devices
- Cooling Wine
- ...



CPC Corporation, Taiwan



WINE COOLER
DIRECT



CHINA STEEL



MATRIX
POWERWATCH





zT & Efficiency

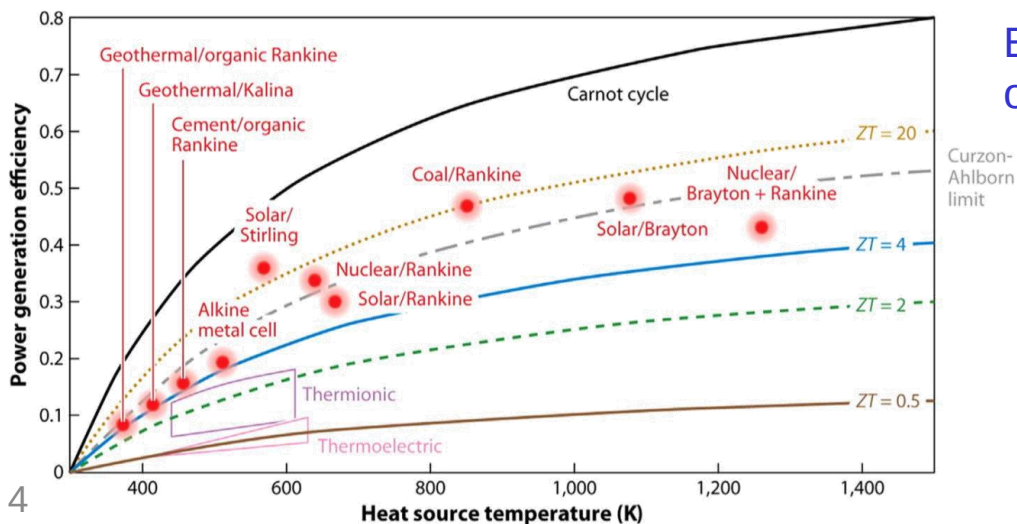
Figure of Merit (zT)

$$zT = \frac{\sigma S^2 T}{\kappa}$$

σ :Electrical Conductivity

$S = \frac{\Delta V}{\Delta T}$: Seebeck Coefficient

$\kappa = \kappa_e + \kappa_l$: Thermal Conductivity



Efficiency comparison between TEG and other energy-conversion technologies.

$$\eta = \frac{\Delta T}{T_h} \left[\frac{\sqrt{1 + z\bar{T}} - 1}{\sqrt{1 + z\bar{T}} + T_c / T_h} \right]$$

He, J. & Tritt, T. M. Advances in thermoelectric materials research: Looking back and moving forward. Science 357, 1369 (2017).



zT & Efficiency

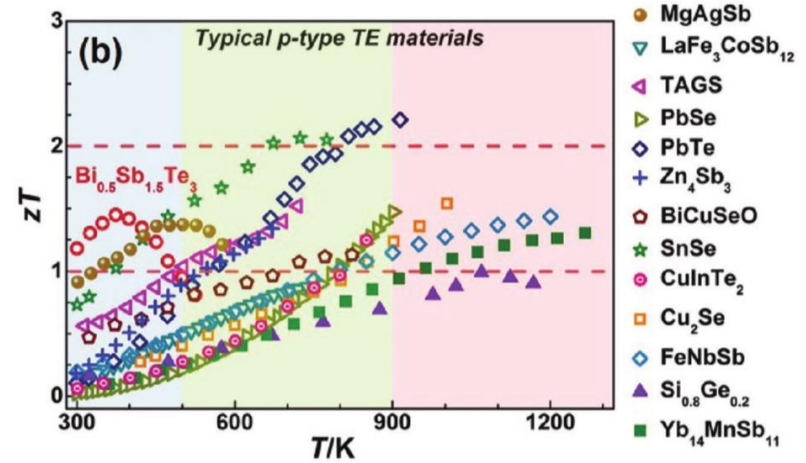
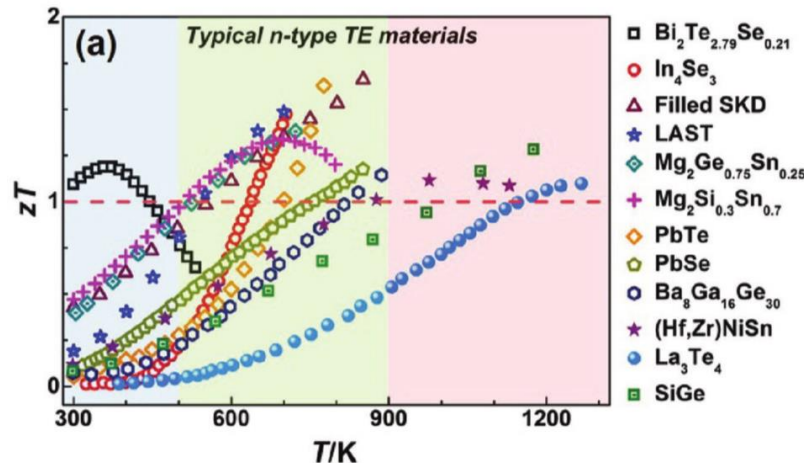
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zT of Metals

Wiedemann -Franz Law

$$R_e = \frac{\sigma}{\kappa_e R_{WF}} \approx 1$$

$$R_{WF} = \frac{3e^2}{\pi^2 k_B^2 T}$$

zT of metals

$$zT \approx \frac{3}{\pi^2} R_e S_r^2 \approx 0.3 S_r^2$$

$$S_r = \frac{S}{k_B / e} \quad (\text{Reduced Seebeck coefficient})$$

$$\frac{k_B}{e} = 86 \text{ } (\mu\text{VK}^{-1})$$

Seebeck Coefficient of Metals

Material	S (uV/K)	S _r	z _{cal} T
Antimony	42	0.49	0.07
Nichrome	20	0.23	0.02
Molybdenum	5	0.06	>0.01
Cadmium, tungsten	2.5	0.03	>0.01
Gold, silver, copper	1.5	0.02	>0.01
Rhodium	1.0	0.01	>0.01

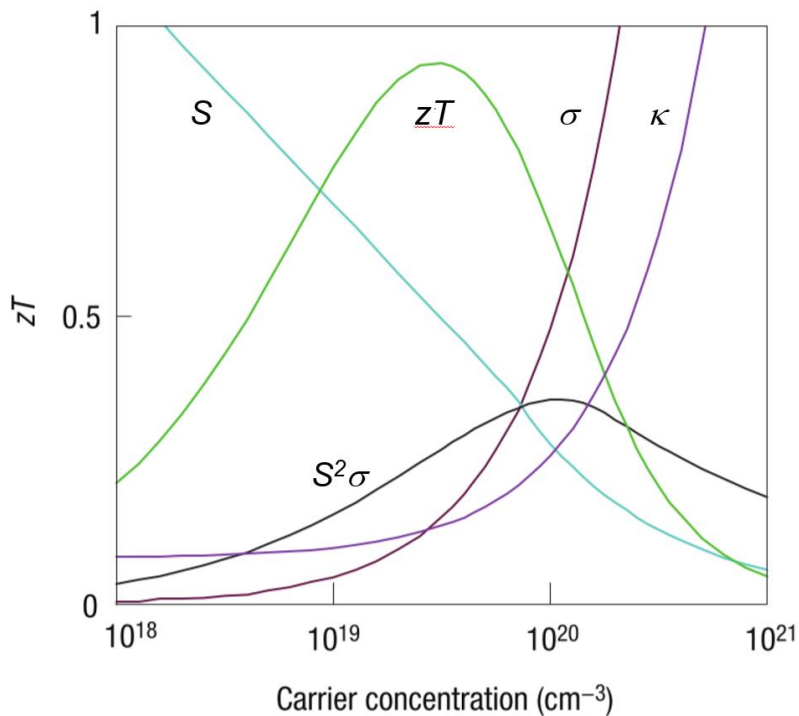
Material	S (uV/K)	S _r	z _{cal} T
Tantalum	-0.5	-0.01	>0.01
Lead	-1	-0.01	>0.01
Carbon	-2	-0.02	>0.01
Mercury	-4.4	-0.05	>0.01
Platinum	-5	-0.06	>0.01
Sodium	-7.0	-0.08	>0.01
Potassium	-14.0	-0.16	>0.01
Nickel	-20	-0.23	>0.01
Constantan	-40	-0.46	0.06
Bismuth	-77	0.89	0.24

https://en.wikipedia.org/wiki/Seebeck_coefficient



Trade-off between TE Parameters in Semiconductors

$$zT = \frac{\sigma S^2 T}{\kappa_l + \kappa_e}$$



- There has to be a trade-off between the electrical conductivity and the magnitude of Seebeck coefficient.
- The zT can be enhanced by reducing the lattice thermal conductivity. This mostly achieved by introducing defects.
- However, defects could significantly impair the electrical conductivity deteriorating the TE performance.



Strongly Enhanced Thermoelectric Performance over a Wide Temperature Range in Topological Insulator Thin Films

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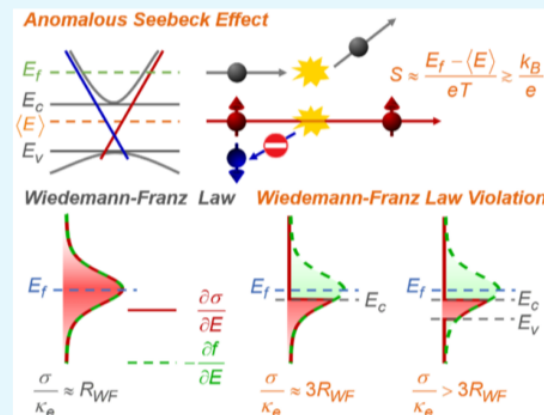
Physics Division, National Center for Theoretical Sciences, Hsinchu 30013, Taiwan

Institute of Physics, Academia Sinica, Taipei 11529, Taiwan

Supporting Information

ABSTRACT: Thermoelectric (TE) devices have been attracting increasing attention because of their ability to convert heat directly to electricity. To date, improving the TE figure of merit remains the key challenge. The advent of the topological insulator and the emerging nanotechnology open a new way to design high-performance TE devices. By combining first-principles calculations with Boltzmann transport theory, we demonstrate for epitaxial Bi_2Se_3 thin films with thickness slightly larger than six quintuple layers, the relaxation time of the in-gap topological surface states can reach hundreds of femtoseconds, which is 2 orders of magnitude larger than that of the bulk states. Such a strong relaxation time enhancement achieves an approximately 3 times larger electrical- to thermal-conductance ratio than the value predicted by the Wiedemann–Franz law. This condition also enhances the Seebeck coefficient, and consequently leads to the excellent TE figure of merit $zT \sim 2.1$ at room temperature with high TE efficiency over a wide temperature range. The TE performance can be further improved by introducing defects in the bulk-like middle layers of the thin film. The improvement is significant at room temperature and can be even better at a higher temperature. Similar strong enhancement of TE performance is expected in other topological insulator thin films.

KEYWORDS: thermoelectric, topological insulator, Bi_2Se_3 thin film, Wiedemann–Franz law violation, anomalous Seebeck effect

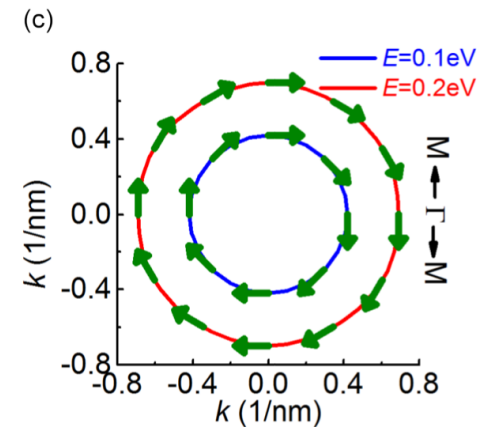
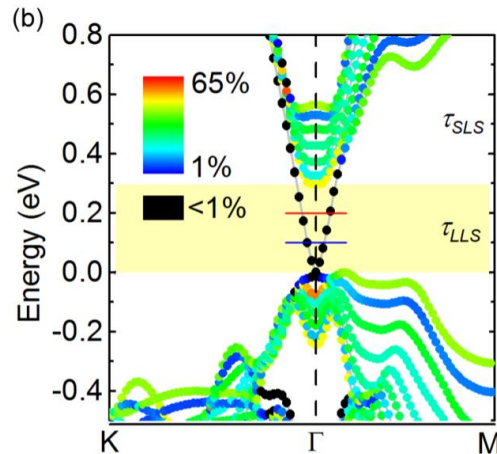
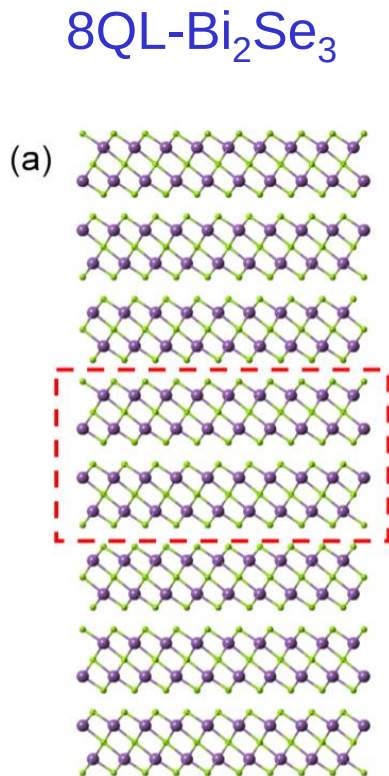




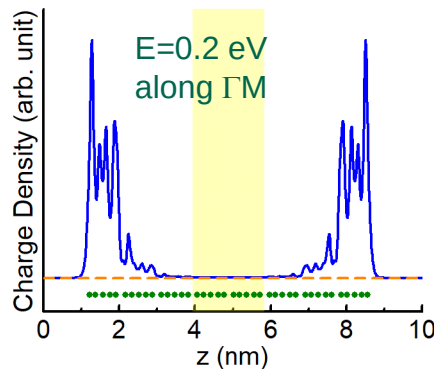
Topological-Insulator Thin Film

No bulk states in LLS region

Large-angle scattering is suppressed



Negligible Interaction between the TSSs at opposite side



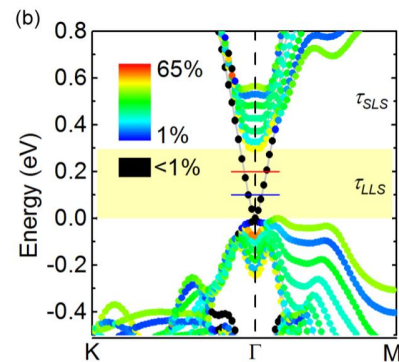
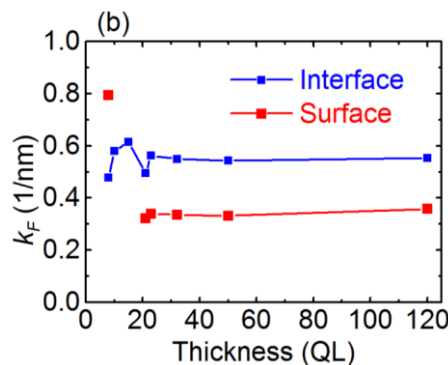
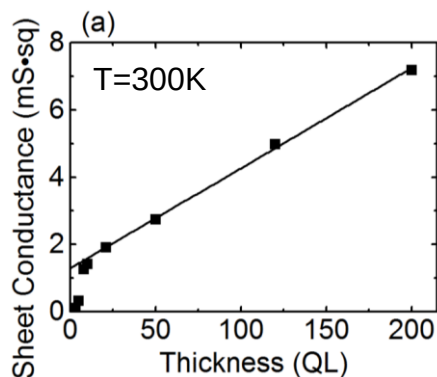
$$\tau_{LLS} \square \tau_{SLS}$$

τ_{SLS} can be significant reduced without noticeable changing τ_{LLS} by introducing defect



Experimental Evidence of Large LLS Relaxation Time

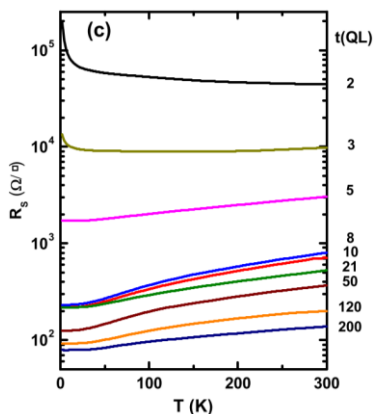
Electrical conductance (exp.) + Fermi wave number (exp.) + Dispersion Relation (DFT)



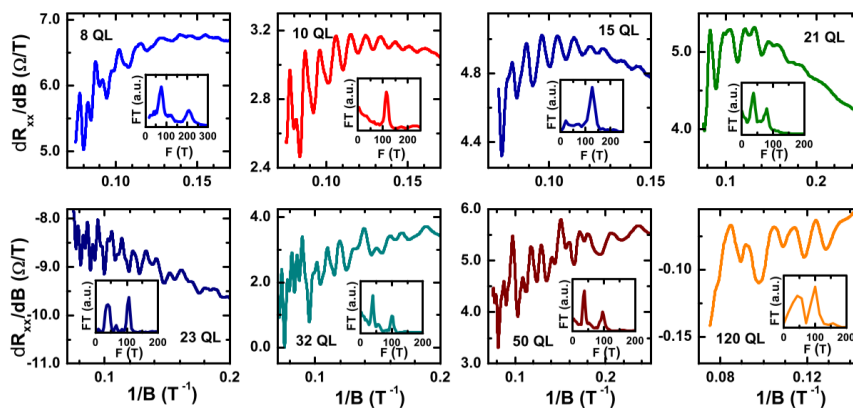
Cf.
BTE & Exp.

$$\tau_{LLS} \approx 230 \text{ fs}$$

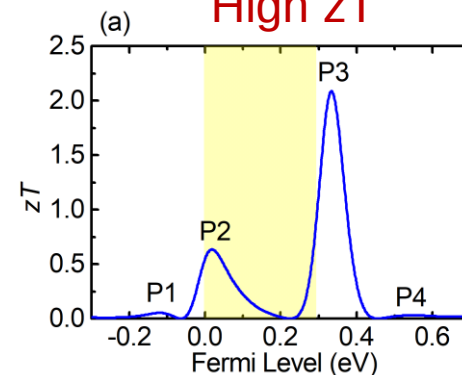
Sheet resistance



Spectra Shubnikov-de Haas Oscillation

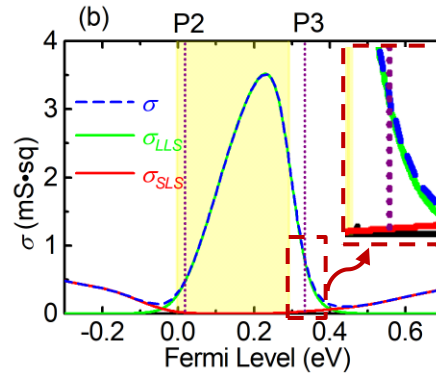
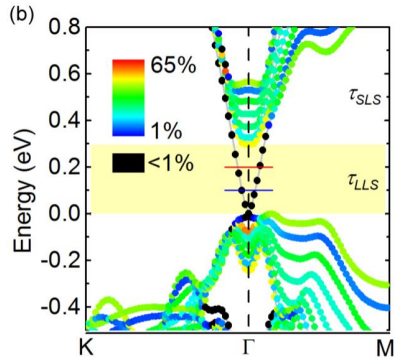


High zT





Anomalous Seebeck Effect



TE transport in dual channels

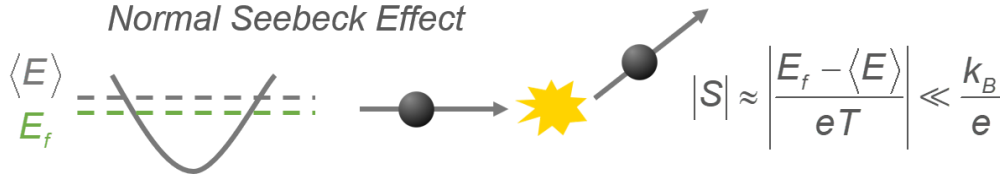
$$\sigma = \sigma_{LLS} + \sigma_{SLS}$$

$$S = \frac{\sigma_{LLS} S_{LLS} + \sigma_{SLS} S_{SLS}}{\sigma_{LLS} + \sigma_{SLS}}$$

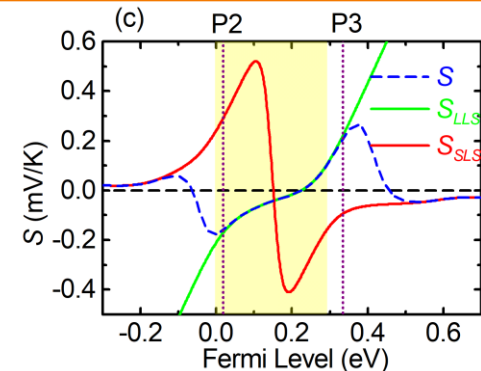
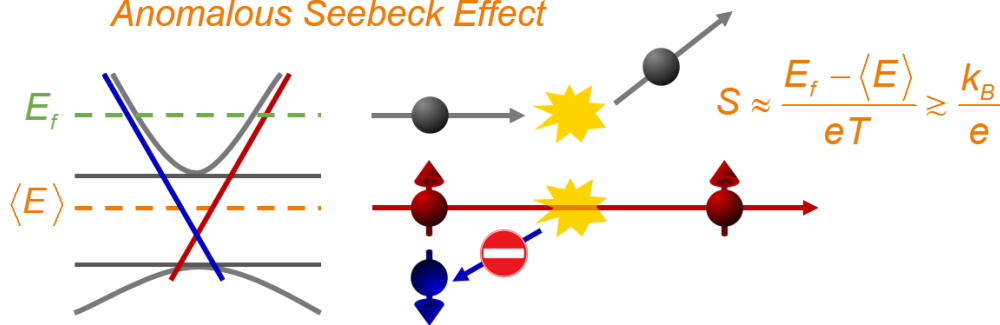
$$S = \frac{E_F - \langle E \rangle}{eT}$$

$$\langle E \rangle = \frac{\int E \sigma(E) dE}{\int \sigma(E) dE}$$

Normal Seebeck Effect



Anomalous Seebeck Effect





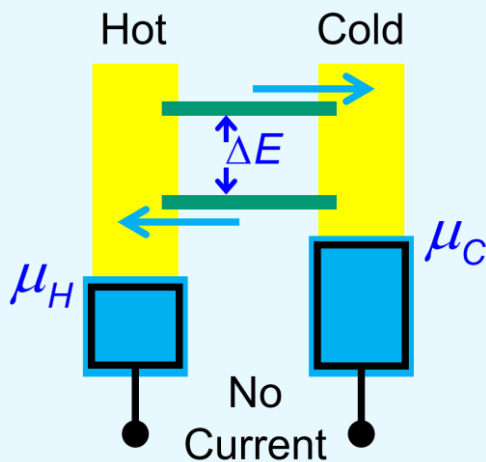
Insight of Wiedemann-Franz Law

Wiedemann-Franz Law

$$\frac{\sigma}{\kappa_e} = R_{WF} = \frac{3e^2}{\pi^2 k_B^2 T}$$

Indicating both charge and electronic heat currents are guided by the same scattering mechanisms

How electrons carry heat?



Solution of BTE

$$\frac{\sigma}{\kappa_e} = \frac{\pi^2}{3\delta} \times R_{WF}$$

$$\delta = \langle \varepsilon^2 \rangle - \langle \varepsilon \rangle^2$$

$$\langle \varepsilon^n \rangle \equiv \int d\varepsilon \varepsilon^n \sigma_d(\varepsilon) / \int d\varepsilon \sigma_d(\varepsilon)$$

$$\sigma = \int d\varepsilon \sigma_d(\varepsilon), \quad \varepsilon = \frac{E}{k_B T}$$

$$\sigma_d(\varepsilon) = \left(-\frac{\partial f}{\partial \varepsilon} \right) \Sigma$$

Σ : Transport distribution function

δ is the reduced-energy variance of the differential conductivity; It is the only factor determine the extent of Wiedemann-Franz law violation!



Violation of Wiedemann-Franz law

Solution of BTE

$$R_e = \frac{\sigma}{\kappa_e R_{WF}} = \frac{\pi^2}{3\delta}$$

$$\delta = \langle \varepsilon^2 \rangle - \langle \varepsilon \rangle^2$$

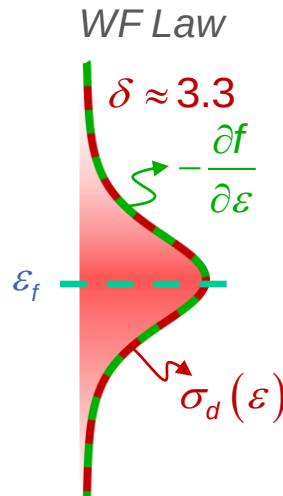
$$\langle \varepsilon^n \rangle \equiv \int d\varepsilon \varepsilon^n \sigma_d(\varepsilon) / \int d\varepsilon \sigma_d(\varepsilon)$$

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Σ : Transport distribution function

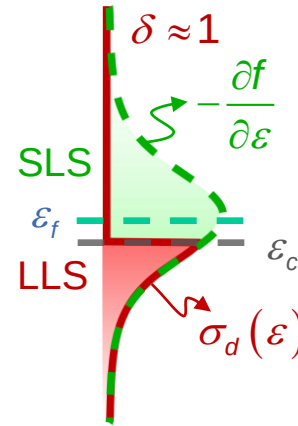
$$R_{WF} = \frac{3e^2}{\pi^2 k_B^2 T}$$

$$\varepsilon = \frac{E}{k_B T}$$

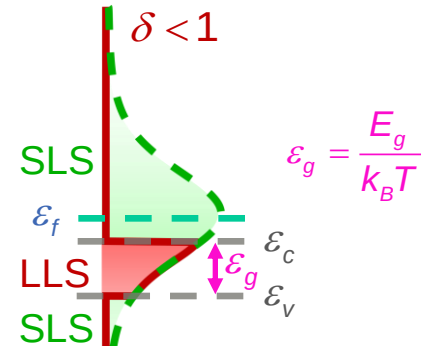


$$R_e \approx 1$$

WF Law Violation



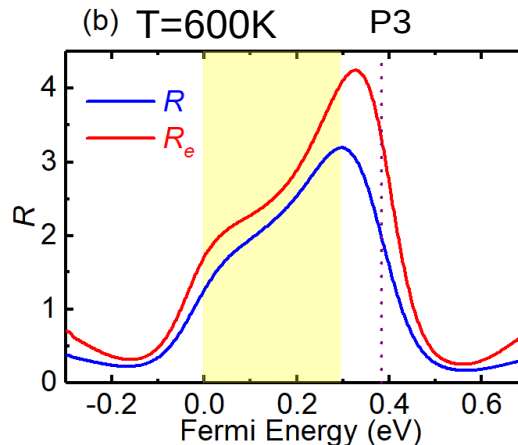
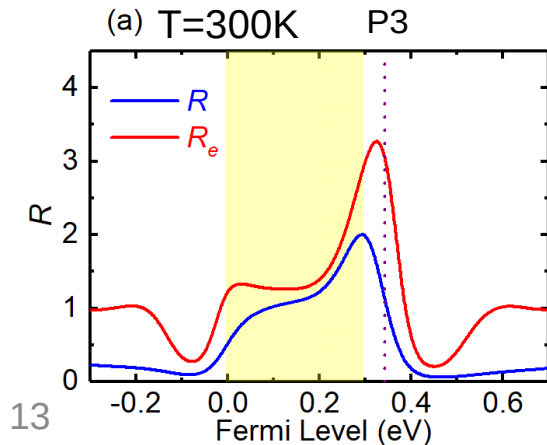
$$R_e^{(\tau_{SLS}=0)} \approx 3.3$$



$$R_e^{(\tau_{SLS}=0)} > 3.3$$

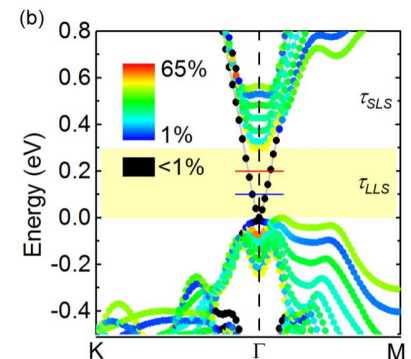
$$\varepsilon_f = \frac{E_f}{k_B T}$$

$$\varepsilon_{c,v} = \frac{E_{c,v}}{k_B T}$$



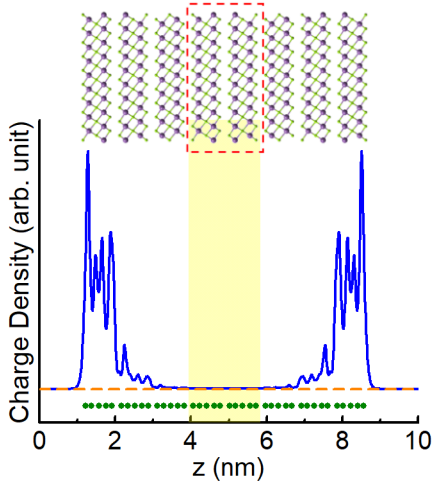
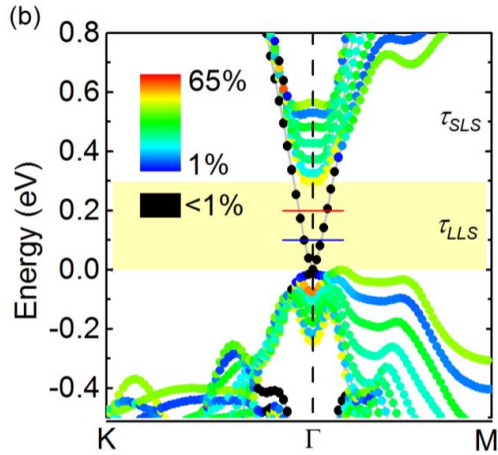
$$R = \frac{\sigma}{\kappa R_{WF}}$$

$$R_e = \frac{\sigma}{\kappa_e R_{WF}}$$





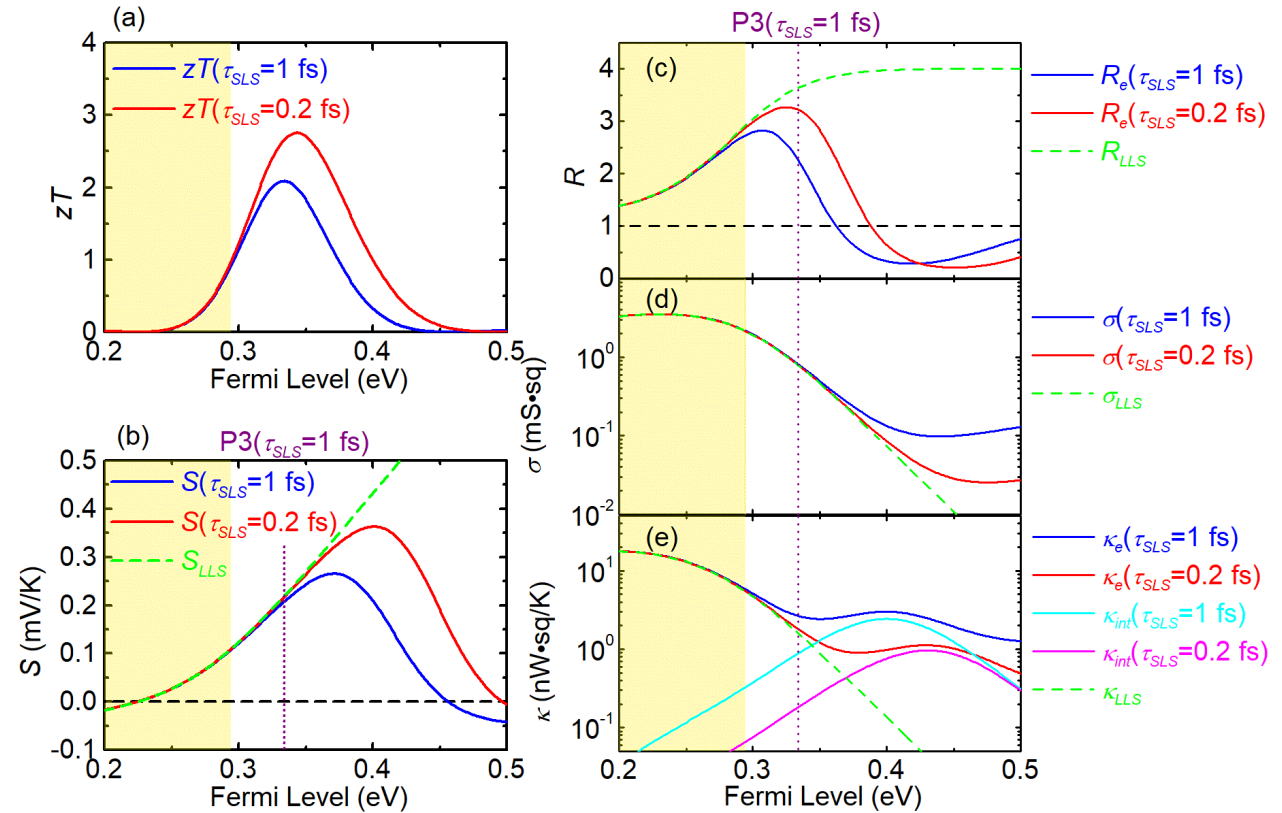
Enhance zT by Introducing Defects



By introducing defect into the bulk like middle layers, we can significantly reduce the SLS relaxation time τ_{SLS} without noticeably deteriorating the LLS relaxation time τ_{LLS} . This causes a further enhancement of the TE performance.

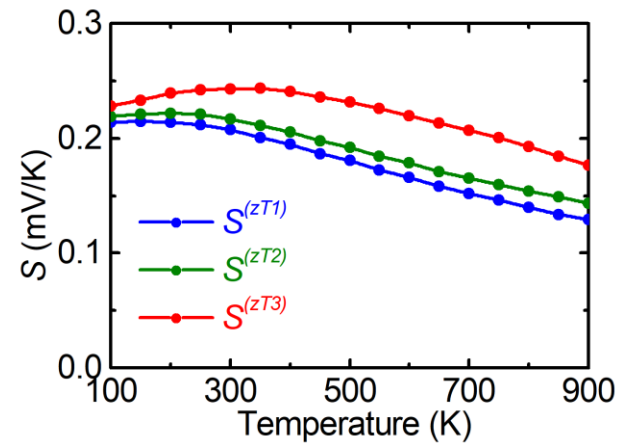
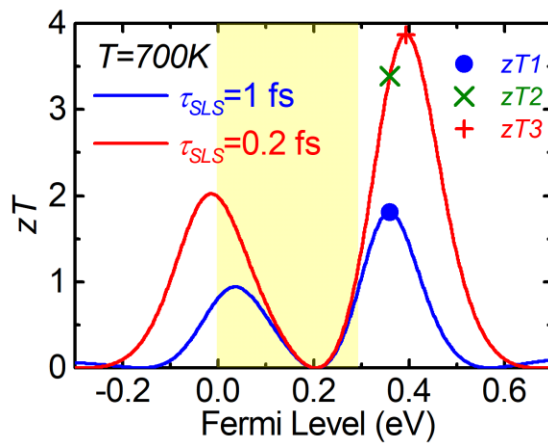
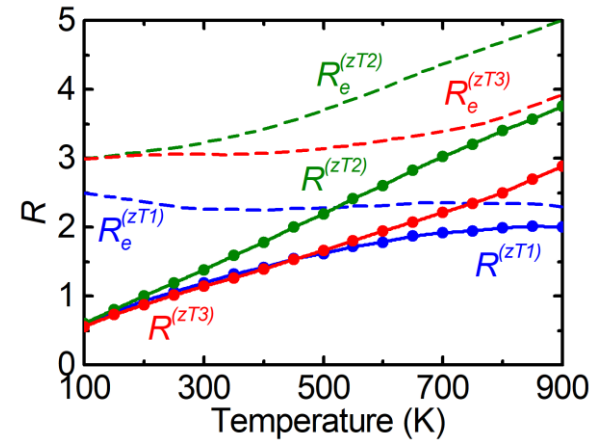
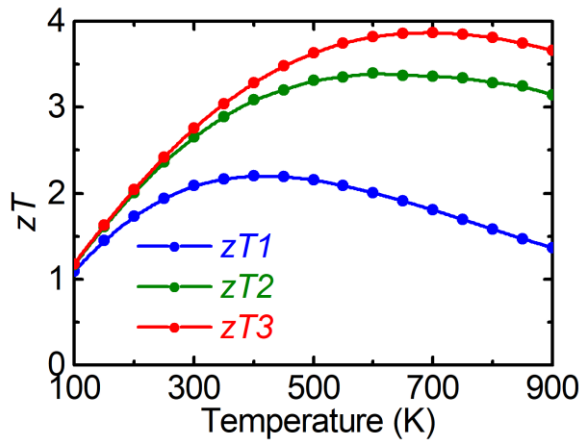
$$\sigma = \sigma_{LLS} + \sigma_{SLS}$$

$$K_e = K_{LLS} + K_{SLS} + K_{int}$$





Temperature-dependence of TE performance





Conclusions

